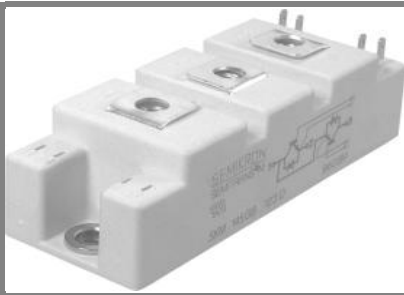


# SKM 75GB124D



**SEMITRANS™ 2**

## Low Loss IGBT Modules

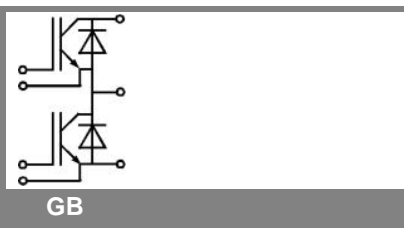
### SKM 75GB124D

#### Features

- MOS input (voltage controlled)
- N channel, homogeneous Si-structure (NPT-Non punch-through IGBT)
- Low loss high density chips
- Low tail current
- High short circuit capability, self limiting to  $6 \times I_{Cnom}$
- Latch-up free
- Fast & soft inverse CAL diodes
- Isolated copper baseplate using DCB Direct Copper Bonding Technology without hard mould
- Large clearance (10 mm) and creepage distance (20 mm)

#### Typical Applications

- Switching (not for linear use)



Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ , unless otherwise specified	
Symbol	Conditions	Values	Units
<b>IGBT</b>			
$V_{CES}$		1200	V
$I_C$	$T_c = 25 (75)^\circ\text{C}$	100 (75)	A
$I_{CRM}$	$t_p = 1 \text{ ms}$	100	A
$V_{GES}$		$\pm 20$	V
$T_{vj}$ ( $T_{stg}$ )	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	$^\circ\text{C}$
$V_{isol}$	AC, 1 min.	2500	V
<b>Inverse diode</b>			
$I_F$	$T_c = 25 (80)^\circ\text{C}$	75 (50)	A
$I_{FRM}$	$t_p = 1 \text{ ms}$	100	A
$I_{FSM}$	$t_p = 10 \text{ ms}$ ; sin.; $T_j = 150^\circ\text{C}$	550	A

Characteristics		$T_c = 25^\circ\text{C}$ , unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
<b>IGBT</b>					
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 2 \text{ mA}$	4,5	5,5	6,5	V
$I_{CES}$	$V_{GE} = 0$ , $V_{CE} = V_{CES}$ , $T_j = 25 (125)^\circ\text{C}$		0,1	0,3	mA
$V_{CE(TO)}$	$T_j = 25 (125)^\circ\text{C}$		1,1 (1,1)	1,25 (1,25)	V
$r_{CE}$	$V_{GE} = 15 \text{ V}$ , $T_j = 25 (125)^\circ\text{C}$		20 (2,6)	2,4 (3,2)	m $\Omega$
$V_{CE(sat)}$	$I_{Cnom} = 50 \text{ A}$ , $V_{GE} = 15 \text{ V}$ , chip level		2,1 (2,4)	2,45 (2,85)	V
$C_{ies}$	under following conditions		3,3	4,3	nF
$C_{oes}$	$V_{GE} = 0$ , $V_{CE} = 25 \text{ V}$ , $f = 1 \text{ MHz}$		0,5	0,6	nF
$C_{res}$			0,22	0,3	nF
$L_{CE}$				30	nH
$R_{CC+EE'}$	res., terminal-chip $T_c = 25 (125)^\circ\text{C}$		0,75 (1)		m $\Omega$
$t_{d(on)}$	$V_{CC} = 600 \text{ V}$ , $I_{Cnom} = 50 \text{ A}$		60	100	ns
$t_r$	$R_{Gon} = R_{Goff} = 22 \Omega$ , $T_j = 125^\circ\text{C}$		55	100	ns
$t_{d(off)}$	$V_{GE} = \pm 15 \text{ V}$		420	500	ns
$t_f$			50	100	ns
$E_{on} (E_{off})$			8 (6)		mJ
<b>Inverse diode</b>					
$V_F = V_{EC}$	$I_{Fnom} = 50 \text{ A}$ ; $V_{GE} = 0 \text{ V}$ ; $T_j = 25 (125)^\circ\text{C}$		2 (1,8)	2,5	V
$V_{(TO)}$	$T_j = 25 (125)^\circ\text{C}$		1,1	1,2	V
$r_T$	$T_j = 25 (125)^\circ\text{C}$			22	m $\Omega$
$I_{RRM}$	$I_{Fnom} = 50 \text{ A}$ ; $T_j = 125 ( )^\circ\text{C}$		39		A
$Q_{rr}$	$di/dt = \text{A}/\mu\text{s}$		7		$\mu\text{C}$
$E_{rr}$	$V_{GE} = \text{V}$				mJ
<b>Thermal characteristics</b>					
$R_{th(j-c)}$	per IGBT			0,27	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,6	K/W
$R_{th(c-s)}$	per module			0,05	K/W
<b>Mechanical data</b>					
$M_s$	to heatsink M6	3		5	Nm
$M_t$	to terminals M5	2,5		5	Nm
w				160	g

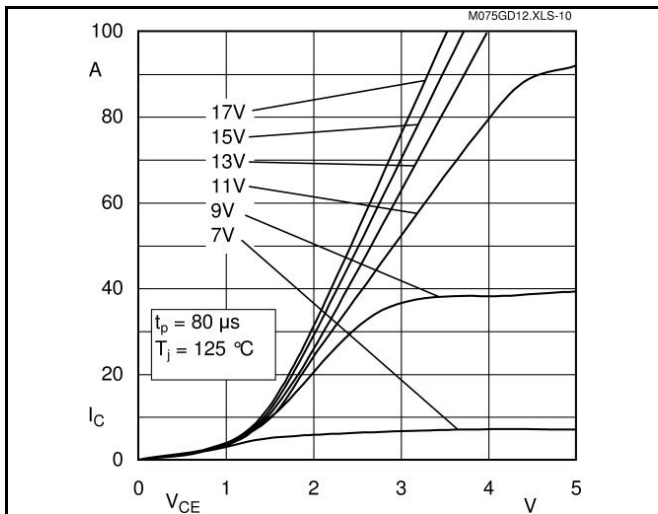


Fig. 1 Typ. output characteristic, inclusive  $R_{CC+EE}$

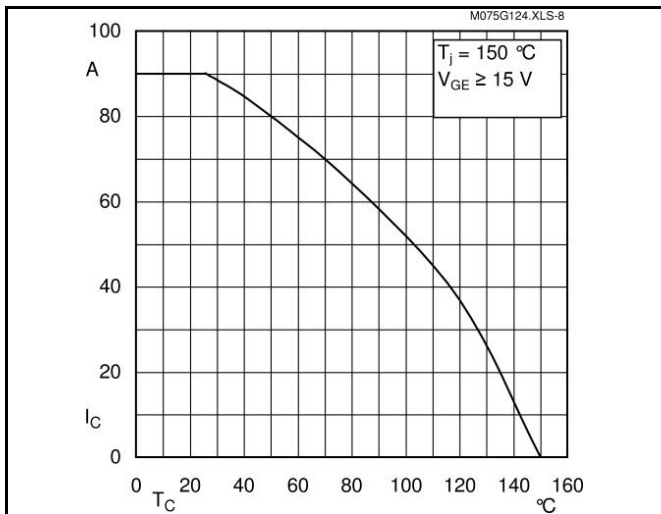


Fig. 2 Rated current vs. temperature  $I_C = f(T_C)$

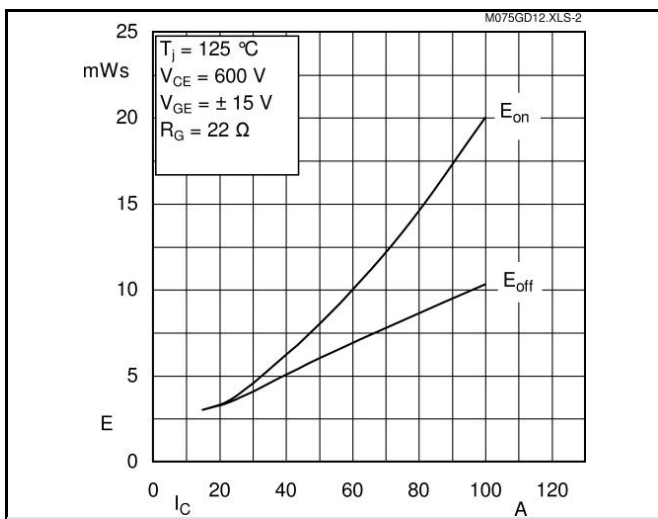


Fig. 3 Typ. turn-on /-off energy =  $f(I_C)$

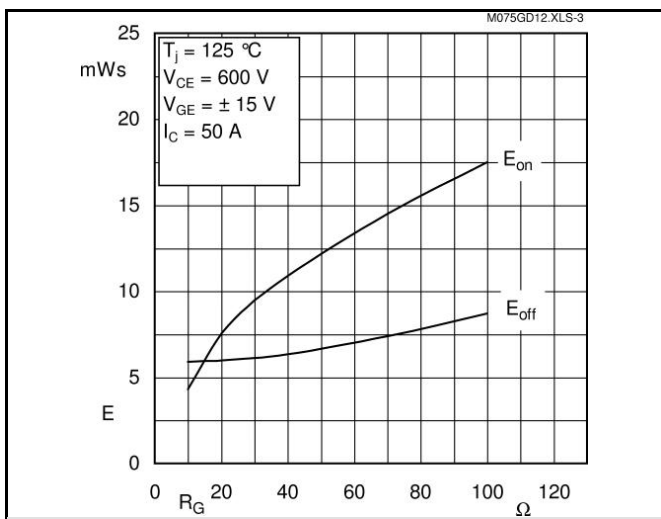


Fig. 4 Typ. turn-on /-off energy =  $f(R_G)$

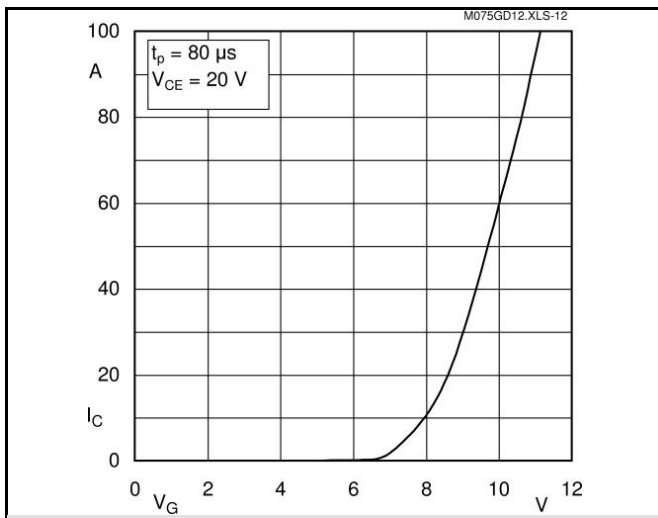


Fig. 5 Typ. transfer characteristic

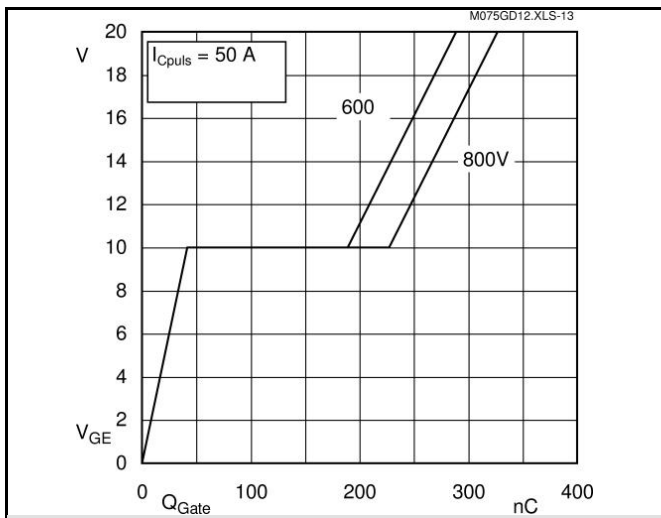
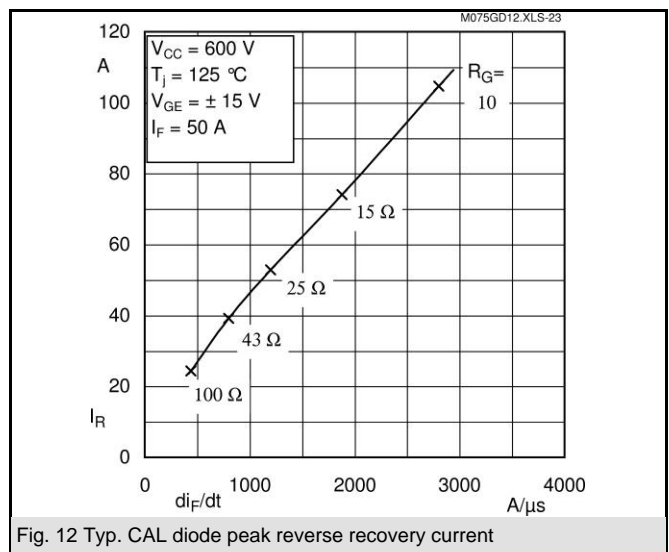
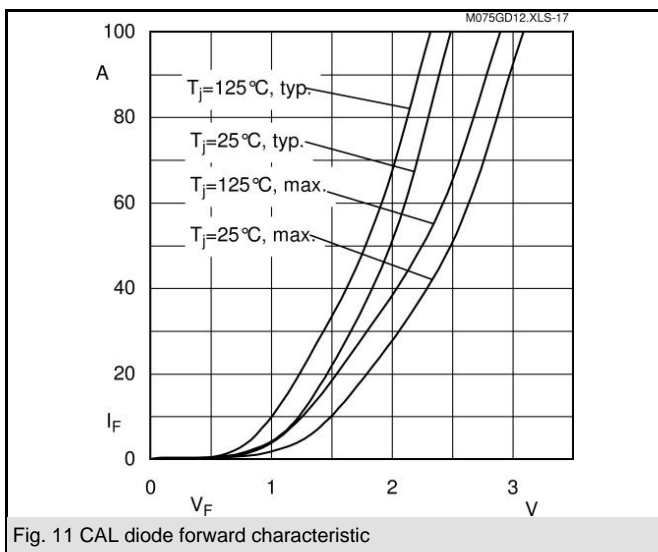
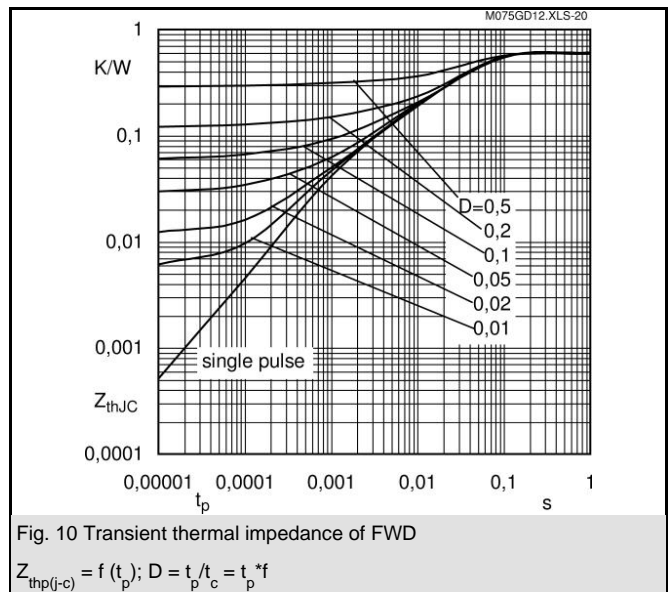
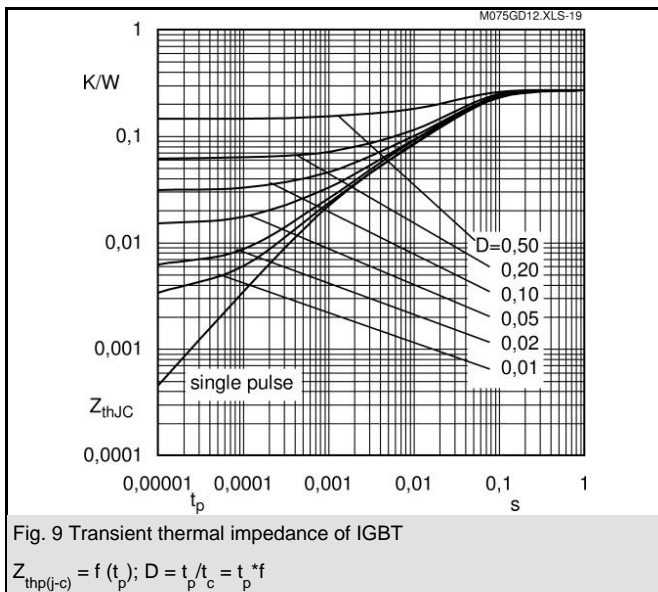
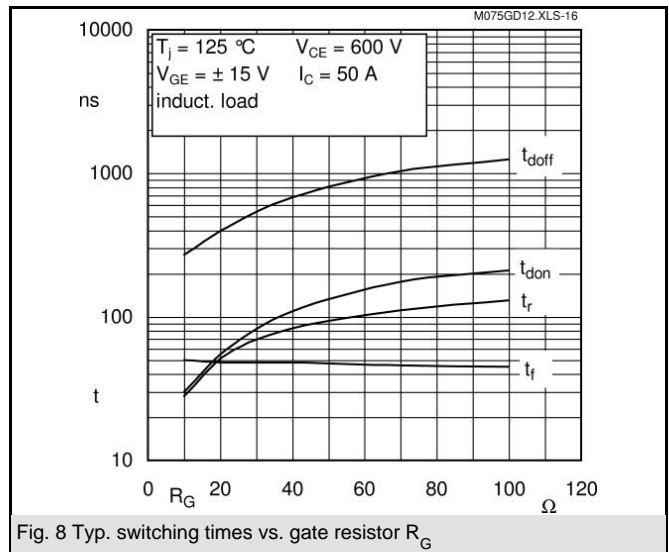
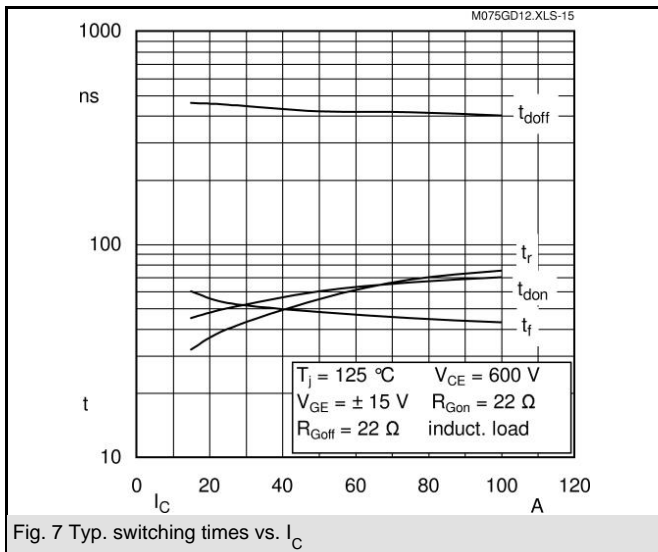
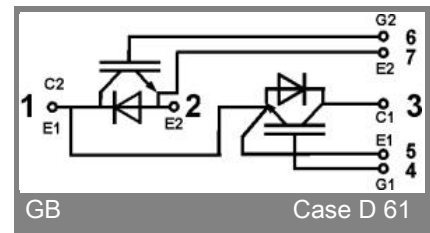
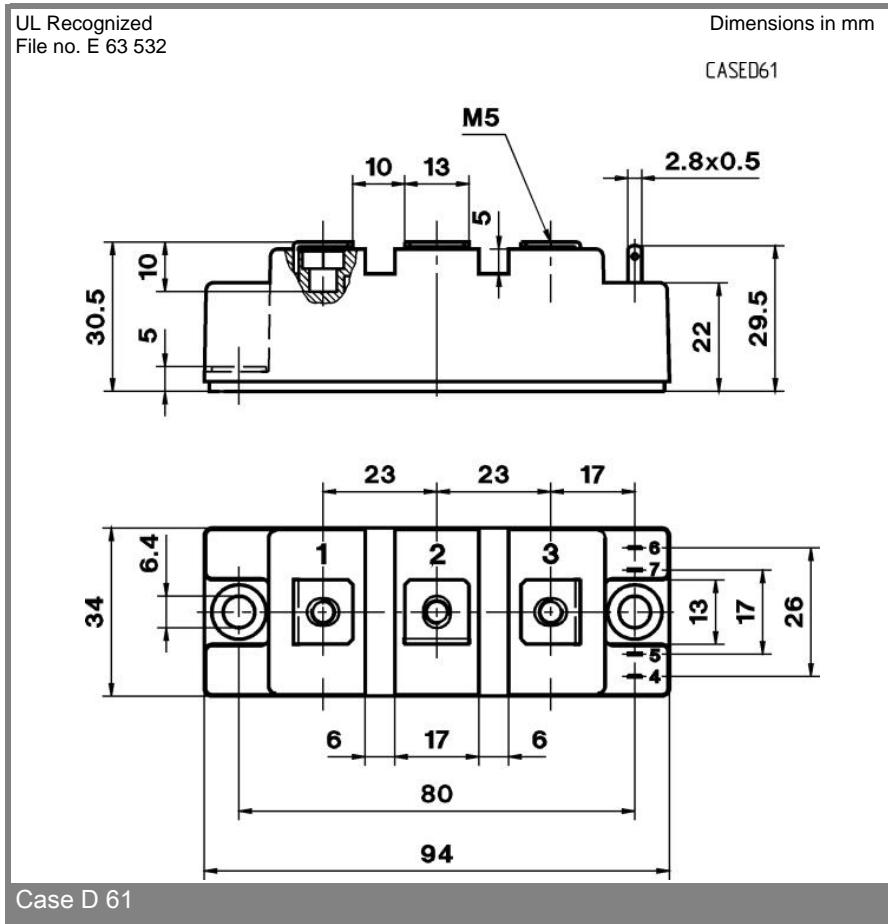
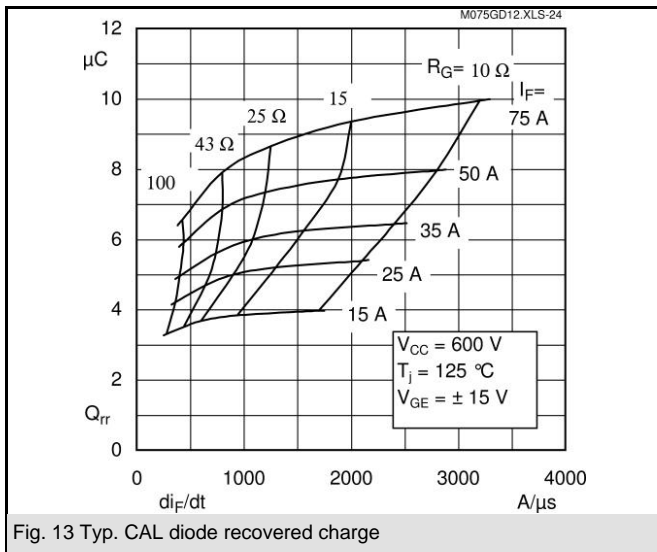


Fig. 6 Typ. gate charge characteristic

Downloaded from [Elcodis.com](http://Elcodis.com) electronic components distributor



# SKM 75GB124D



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.